

Search Notes

Application/Control No.

10/543,118

Examiner

Hanh V. Tran

Applicant(s)/Patent under
Reexamination

BAUER ET AL.

Art Unit

3637

SEARCHED

Class	Subclass	Date	Examiner
312	405 405.1	9/29/2007	HVT
	401 406		
	116 138.1		
312	321.5		
62	125 126	9/29/2007	HVT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East text search using various key words	9/29/2007	HVT